

EMK13 H 2 J -66.660M

Series RoHS Compliant (Pb-free) 4 Pad 5mm x 7mm SMD 3.3Vdc LVCMOS MEMS Oscillator

Frequency Tolerance/Stability ±50ppm Maximum over -40°C to +85°C Duty Cycle -50 ±5(%) Nominal Frequency
66.660MHz

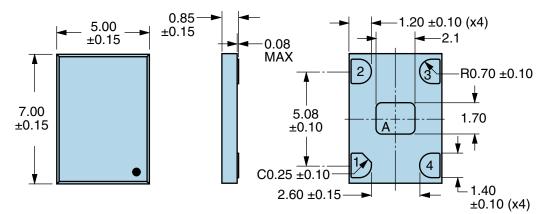
Output Control Function
Power Down (Disabled Output: Logic Low)

ELECTRICAL SPECIFICATIONS			
Nominal Frequency	66.660MHz		
Frequency Tolerance/Stability	±50ppm Maximum over -40°C to +85°C (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, 260°C Reflow, Shock, and Vibration)		
Aging at 25°C	±1ppm Maximum First Year		
Operating Temperature Range	-40°C to +85°C		
Supply Voltage	3.3Vdc ±10%		
Input Current	25mA Maximum		
Output Voltage Logic High (Voh)	90% of Vdd Minimum (IOH=-8mA)		
Output Voltage Logic Low (Vol)	10% of Vdd Maximum (IOL=+8mA)		
Rise/Fall Time	2nSec Maximum (Measured from 20% to 80% of waveform)		
Duty Cycle	50 ±5(%) (Measured at 50% of waveform)		
Load Drive Capability	15pF Maximum		
Output Logic Type	CMOS		
Output Control Function	Power Down (Disabled Output: Logic Low)		
Output Control Input Voltage	+0.7Vdd Minimum or No Connect to Enable Output, +0.3Vdd Maximum to Disable Output		
Standby Current	50μA Maximum (Disabled Output: Logic Low)		
Peak to Peak Jitter (tPK)	250pSec Maximum, 100pSec Typical		
Start Up Time	50mSec Maximum		
Storage Temperature Range	-55°C to +125°C		

ENVIRONMENTAL & MECHANICAL SPECIFICATIONS			
ESD Susceptibility	MIL-STD-883, Method 3015, Class 2, HBM 2000V		
Flammability	UL94-V0		
Mechanical Shock	MIL-STD-883, Method 2002, Condition G, 30,000G		
Moisture Resistance	MIL-STD-883, Method 1004		
Moisture Sensitivity Level	J-STD-020, MSL 1		
Resistance to Soldering Heat	MIL-STD-202, Method 210, Condition K		
Resistance to Solvents	MIL-STD-202, Method 215		
Solderability	MIL-STD-883, Method 2003 (Four I/O Pads on bottom of package only)		
Temperature Cycling	MIL-STD-883, Method 1010, Condition B		
Thermal Shock	MIL-STD-883, Method 1011, Condition B		
Vibration	MIL-STD-883, Method 2007, Condition A, 20G		



MECHANICAL DIMENSIONS (all dimensions in millimeters)



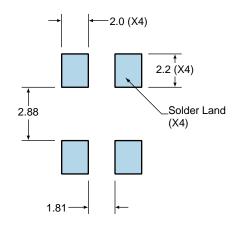
Note A: Center paddle is connected
internally to oscillator ground (Pad 2).

PIN CONNECTION 1 Power Down (Logic Low) 2 Ground 3 Output 4 Supply Voltage

LINE	MARKING
1	XXXX or XXXXX
	XXXX or XXXXX=Ecliptek Manufacturing Lot Code
	Manufacturing Lot Code

Suggested Solder Pad Layout

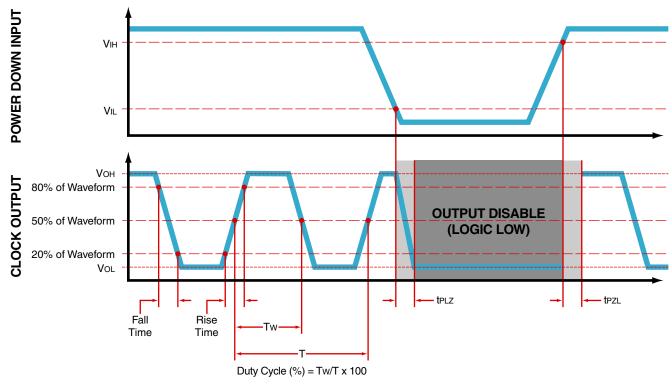
All Dimensions in Millimeters



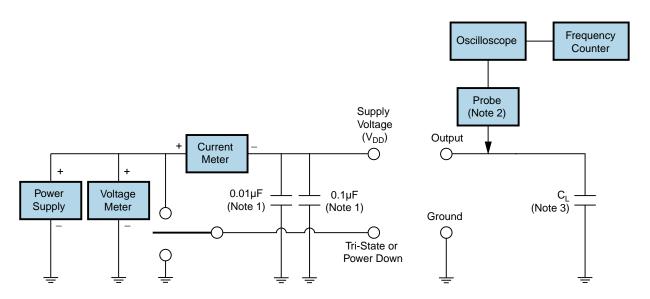
All Tolerances are ±0.1



OUTPUT WAVEFORM & TIMING DIAGRAM



Test Circuit for CMOS Output



- Note 1: An external $0.1\mu\text{F}$ low frequency tantalum bypass capacitor in parallel with a $0.01\mu\text{F}$ high frequency ceramic bypass capacitor close to the package ground and V_{DD} pin is required.
- Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.
- Note 3: Capacitance value \dot{C}_L includes sum of all probe and fixture capacitance.



Recommended Solder Reflow Methods



High Temperature Infrared/Convection

T _s MAX to T _∟ (Ramp-up Rate)	3°C/second Maximum
Preheat	
- Temperature Minimum (T _s MIN)	150°C
- Temperature Typical (T _s TYP)	175°C
- Temperature Maximum (T _S MAX)	200°C
- Time (t _s MIN)	60 - 180 Seconds
Ramp-up Rate (T _L to T _P)	3°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	217°C
- Time (t∟)	60 - 150 Seconds
Peak Temperature (T _P)	260°C Maximum for 10 Seconds Maximum
Target Peak Temperature (T _P Target)	250°C +0/-5°C
Time within 5°C of actual peak (tp)	20 - 40 seconds
Ramp-down Rate	6°C/second Maximum
Time 25°C to Peak Temperature (t)	8 minutes Maximum
Moisture Sensitivity Level	Level 1



Recommended Solder Reflow Methods



Low Temperature Infrared/Convection 240°C

T _S MAX to T _L (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T _s MIN)	N/A
- Temperature Typical (T _S TYP)	150°C
- Temperature Maximum (T _s MAX)	N/A
- Time (t _s MIN)	60 - 120 Seconds
Ramp-up Rate (T _L to T _P)	5°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T _P)	240°C Maximum
Target Peak Temperature (T _P Target)	240°C Maximum 1 Time / 230°C Maximum 2 Times
Time within 5°C of actual peak (tp)	10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1

Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum.